## leeun Classification

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Application/Control No.	
10575005	

10575985 YOGESH K AGGARWAL Applicant(s)/Patent Under Reexamination APARD ET AL.

Examiner

Art Unit 2622

ORIGINAL						INTERNATIONAL CLASSIFICATION																
	CLASS			SUBCLASS		CLAIMED NON-CLAIM						CLAIMED										
348			294			н	0	4	N	3 / 14 (2006.01.01)					3 / 14 (2006.01.01)							
	CR	OSS REF	ERENCE(	S)		#	0	4	N	5 / 335 (2008.01.01)	01)											
CLASS	SUB	SUBCLASS (ONE SUBCLASS PER BLOCK)				Г	Т															
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	Claims renumbered in the same order as presented by applicant							CP	A [	] T.D.		R.1.	47		
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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4	13														
5	14														

NONE	Total Claims Allowed:						
(Assistant Examiner)	(Date)	5					
/YOGESH K AGGARWAL/ Primary Examiner.Art Unit 2622	01/31/2010	O.G. Print Claim(s)	O.G. Print Figure				
(Primary Examiner)	(Date)	1	4				